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FORM PTO-1449	Atty. Docket No.: <b>P32.12-0019</b>	Appl. No.: 09/972,078		
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:			
	Evren Eryurek et al	•		
	Filing Date	Group Art:		
	October 5, 2001	2121		

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Exam Init		Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
N	AA	6,016,523	1/18/00	Zimmerman et al.	710	63	
JV	AB	6,052,655	4/18/00	Kobayashi et al.	702	184	
	AC						
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Exam		Document No.	Date	Na	ame	Class	Sub Class	Filing Date If Appropriate
T	AA	3,618,592	11/9/71	Stewart et	al.	128	2.05	. 1
1	AB	4,668,473	5/26/87	Agarwal		422	62	
	AC	4,720,806	1/19/88	Schippers e	t al.	-364-		Minology 2
	AD	4,736,763	4/12/88	Britton et	al.	137	10	2 2 T
	AE	5,089,979	2/18/92	McEachern e	t al.	-364	<u>-571.04</u>	Celt
	AF	5,365,787	11/22/94	Hernandez e	t al.	73	660	Centrar P100
	AG	5,436,705	7/25/95	Raj		355	246	210
	AH	5,526,293	6/11/96	Mozumder et	al.		<del>- 578</del>	0
	AI	5,539,638	7/23/96	Keeler et a	1.	-364	424.037	
	AJ	5,591,922	1/7/97	Segeral et	Segeral et al.		861.04	
	AK	5,633,809	5/27/97	Wissenbach	et al.	<del>- 364</del> -	<u> </u>	
	AL	5,708,211	1/13/98	Jepson et a	1.	73	861.04	
	AM	5,710,370	1/20/98	Shanahan et	al.	73	1.35	
	AN	5,736,649	4/7/98	Kawasaki et	al.	73	861.23	
	AO	5,747,701	5/5/98	Marsh et al	•	73	861.23	
	AP	5,817,950	10/6/98	Wiklund et	al.	73	861.66	
	AQ	5,908,990	6/1/99	Cummings		73	861.22	
	AR	6,072,150	6/6/00	Sheffer		219	121.83	
	AS	6,112,131	8/29/00	Ghorashi et	al.	700	142	
	AT	6,119,529	9/19/00	DiMarco et al.		73	861.68	
	AU	6,236,948	5/22/01	Eck et al.		702	45	
V.	AV	6,311,136	10/30/01	Henry et al.		702	45	
T	₩A	6,327,914	12/11/01	Dutton		73	861.356	
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LIST	OF PATENTS AND PUBLICATIONS FOR IPE APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:	
	MAY 1 5 2002	Evren Eryurek et al.	
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TV	AN	03229124	11/10/91	Japan			X (abstract only)
TV	AO	0 512 794 A2	5/5/92	EPO			Х

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TV	AP	Journal of Intelligent Manufact tool condition monitoring syste	curing (1997) 8, 271-276 article entitled "On-line em with wavelet fuzzy neural network"
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T	AA	5,880,376	3/9/99	Sai et al.	<u> </u>	73	861.08		
TV	AB	6,038,579	3/14/00	Sekine		708	- 400		
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TV	PA	4,249,164	2/3/81	Tivy	340	870.3	
TV	PB	5,469,749	11/28/95	Shimada et al.	73	861.47	
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10102	Evren Eryurek et al	
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T	AA	4,818,994	4/4/89	Orth et al.	340	870.21	······································
TV	AB	6,139,180	10/31/00	Usher et al.	374	1	
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JUN 1 9 2002 3	Evren Eryurek et al	•	
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TV	AN	IEEE Transactions on Magnetics, Vol. 34, No. 5, September 1998, "Optical Design of the Coils of an Electromagnetic Flow Meter," pages 2563-2566			
$\mathcal{N}$	AO	IEEE Transactions on Magnetics, Vol. 30, No. 2, March 1994, "Magnetic Fluid Flow Meter for Gases," pages 936-938			
N	AP	IEEE Instrumentation and Measurement, "New approach to a main error estimation for primary transducer of electromagnetic flow meter," pages 1093-1097			
N	AQ	"Additional Information From Flowmeters via Signal Analysis," by J.E. Amadi- Echendu and E.H. Higham, pages 187-193			
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FORM PTO-1449	Atty. Docket No.: <b>P32.12-0019</b>	Appl. No.: 09/972,078	
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TV	AA	3,855,858	12/24/74	Cushing	73	194	
Z	AB	5,388,465	2/14/95	Okaniwa et al.	73	861.17	· · · · ·
71	AC	5,560,246	10/1/96	Bottinger et al.	73	. 861.15	······································
N	AD	6,014,902	1/18/00	Lewis et al.	73	861.12	
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		Document No.	Date	Country	Class	Sub Class	Translation Yes No
7	AM	11083575	3/26/99	Japan			(Abstract Only)
7	AN	60174915	9/9/85	Japan			(Abstract Only)
T	AO	59163520	9/14/84	Japan			(Abstract Only)

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$\overline{\gamma}$	AP	"Notification of Transmittal of the International Search Report or the Declaration" for PCT/US01/40791.	ре
$\overline{\gamma}$	AQ	"Notification of Transmittal of the International Search Report or the Declaration" for PCT/US01/40782.	1e
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FORM PTO-1449	Atty. Docket No.: <b>P32.12-0019</b>	Appl. No.: <b>09/972,078</b>	
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:		
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T	AA	3,849,637	11/19/74	Caruso et al.	235	151					
-1	AB	3,952,759	4/27/76	Ottenstein	137	12	Tec <b>P</b>				
	AC	4,279,013	7/14/81	Cameron et al.	364	105					
	AD	4,417,312	11/22/83	Cronin et al.	364	510					
	AĖ	4,853,693	8/1/89	Eaton-Williams	340	588	2				
	AF	5,434,774	7/18/95	Seberger	364	172	2 2002 Center				
	AG	5,608,650	3/4/97	McClendon et al.	364	510					
	АН	5,682,317	10/28/97	Keeler et al.	364	431.03					
$\top$	AI	5,828,567	10/27/98	Eryurek et al.	364	184					
	AJ	5,936,514	8/10/99	Anderson et al.	340	310.01					
	AK	6,023,399	2/8/00	Kogure	361	23					
	AL	6,347,252	2/12/02	Behr et al.	700	3					
	AM	6,360,277	3/19/02	Ruckley et al.	709	250					
	AN	6,370,448	4/9/02	Eryurek	700	282	ć.				
	AO	6,397,114	5/28/02	Eryurek et al.	700	51					
TV	AP	6,425,038	7/23/02	Sprecher	710	269					
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FORM PTO-1449	Atty. Docket No.: P32.12-0019	Appl. No.: 09/972,078	
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		Document No.	Date	Country	Class	Sub Class	Translation Yes No
$\overline{\gamma}$	BA	GB 2,347,232	8/30/00	United Kingdom	•		Х
	BB	GB 2,342,453	4/12/00	United Kingdom	-DE		X
	BC	EP 1,022,626	7/26/00	EPO		DEIV	EDx
	BD	WO 98/39718	9/11/98	PCT WIPO	- <del>-0</del> 6	<del>T 0 2</del> 2(	02 ×
V.	BE	WO 99/19782	4/22/99	PCT WIPO	Techno	Day Cont	X
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TV	BG	International Search Report for International Application No. PCT/U issued May 8, 2002. Report dated September 3, 2002.	S 02/14560,			
Z	ВН	International Search Report for International Application No. PCT/US 02/14934, issued May 8, 2002. Report dated August 28, 2002.				
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	FORM PTO-1449	PHILIP ON CONTRACT	Atty. Docket No.: <b>P32.12-0019</b>	Appl. No.: 09/972,078
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iner tial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
AA	Re.29,383	09/06/77	Gallatin et al.	137	14	
AB	3,096,434	07/02/63	King	235 ·	151	•
AC	3,404,264	10/01/68	Kugler	235	194	
AD	3,468,164	09/23/69	Sutherland	73	343 <b>F</b>	ECEIVED
AE	3,590,370	06/29/71	Fleischer	324	51	
AF	3,688,190	08/29/72	Blum	324	61R	
AG	3,691,842	09/19/72	Akeley	73	39aTechr	ology Center 2100
АН	3,701,280	10/31/72	Stroman	73	194	· · · · · · · · · · · · · · · · · · ·
AI	3,973,184	08/03/76	Raber	324	51	
AJ	4,058,975	11/22/77	Gilbert et al.	60	39.28	
AK	4,099,413	07/11/78	Ohte et al.	73	359	
AK	4,102,199	07/25/78	Talpouras	73	362	
AL	4,122,719	10/31/78	Carlson et al.	73	342	
AM	4,250,490	02/10/81	Dahlke	340	870.37	
AN	4,337,516	06/29/82	Murphy et al.	_364_	<del>~-551~</del>	
AO	4,517,468	05/14/85	Kemper et al.	290	52	
AP	4,530,234	07/23/85	Cullick et al.	73	53	
AQ	4,571,689	02/18/86	Hildebrand et al.	364	-481-	
AR	4,635,214	01/06/87	Kasai et al.	-364-	-551-	
AS	4,642,782	02/10/87	Kemper et al.	-364	<del>-550 -</del>	
AT	4,644,479	02/17/87	Kemper et al.	-364	<del>550</del> -	
AU	4,649,515	03/10/87	Thompson et al.	<del>&lt; 361</del>	-900-	
AV	4,707,796	11/17/87	Calabro et al.	_364	- 552	
AW	4,736,367	05/05/88	Wroblewski et al.	370	85	
AX	4,777,585	10/11/88	Kokawa et al.	•364-	-164	
AY	4,831,564	05/16/89	Suga	-364	-551_01	
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	ialAAABACADAEAFAGAHAIAJAKALAKAKALARAQARAQARASATAUAVAWAXAY	ial   AA Re.29,383   AB 3,096,434   AC 3,404,264   AD 3,468,164   AE 3,590,370   AF 3,688,190   AG 3,691,842   AH 3,701,280   AI 3,973,184   AJ 4,058,975   AK 4,099,413   AK 4,102,199   AL 4,122,719   AM 4,250,490   AN 4,337,516   AO 4,517,468   AP 4,635,214   AS 4,642,782   AT 4,644,479   AU 4,649,515   AV 4,707,796   AW 4,736,367   AX 4,777,585   AY 4,831,564	iner cialDocument No. DateAARe.29,38309/06/77AB3,096,43407/02/63AC3,404,26410/01/68AD3,468,16409/23/69AE3,590,37006/29/71AF3,688,19008/29/72AG3,691,84209/19/72AH3,701,28010/31/72AI3,973,18408/03/76AJ4,058,97511/22/77AK4,099,41307/11/78AK4,102,19907/25/78AL4,250,49002/10/81AN4,337,51606/29/82AO4,517,46805/14/85AP4,635,21401/06/87AS4,642,78202/10/81AR4,645,51503/10/87AU4,649,51503/10/87AV4,707,79611/17/87AW4,736,36705/05/88AX4,777,58510/11/88AY4,831,56405/16/89	Iner Hall   Document No.   Date   Name     AA   Re.29,383   09/06/77   Gallatin et al.     AB   3,096,434   07/02/63   King     AC   3,404,264   10/01/68   Kugler     AD   3,468,164   09/23/69   Sutherland     AE   3,590,370   06/29/71   Fleischer     AF   3,688,190   08/29/72   Blum     AG   3,691,842   09/19/72   Akeley     AH   3,701,280   10/31/72   Stroman     AI   3,973,184   08/03/76   Raber     AJ   4,058,975   11/22/77   Gilbert et al.     AK   4,099,413   07/11/78   Ohte et al.     AK   4,102,199   07/25/78   Talpouras     AL   4,122,719   10/31/78   Carlson et al.     AM   4,250,490   02/10/81   Dahlke     AN   4,337,516   06/29/82   Murphy et al.     AO   4,517,468   05/14/85   Kemper et al.     <	Iner ial   Document No.   Date   Name   Class     AA   Re.29,383   09/06/77   Gallatin et al.   137     AB   3,096,434   07/02/63   King   235     AC   3,404,264   10/01/68   Kugler   235     AD   3,468,164   09/23/69   Sutherland   73     AE   3,590,370   06/29/71   Fleischer   324     AF   3,688,190   08/29/72   Blum   324     AG   3,691,842   09/19/72   Akeley   73     AH   3,701,280   10/31/72   Stroman   73     AI   3,973,184   08/03/76   Raber   324     AJ   4,058,975   11/22/77   Gilbert et al.   60     AK   4,099,413   07/11/78   Ohte et al.   73     AL   4,122,719   10/31/72   Stroman   73     AL   4,250,490   02/10/81   Dahke   340     AN   4,337,516   06/29/82   Murphy e	iner ital   Document No.   Date   Name   Class   Sub Class     AA   Re.29,383   09/06/77   Gallatin et al.   137   14     AB   3,096,434   07/02/63   King   235   151     AC   3,404,264   10/01/68   Kugler   235   194     AD   3,468,164   09/23/69   Sutherland   73   343   F     AE   3,590,370   06/29/71   Fleischer   324   61R     AG   3,691,842   09/19/72   Akeley   73   393   393     AH   3,701,280   10/31/72   Stroman   73   194     AI   3,973,184   08/03/76   Raber   324   51     AJ   4,058,975   11/22/77   Gilbert et al.   73   359     AK   4,099,413   07/11/78   Ohte et al.   73   362     AL   4,122,719   10/31/78   Carlson et al.   73   342     AM   4,250,490   0

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		Evren Eryurek et al.		
		Filing Date	Group Art:	
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TV	BB	4,873,655	10/10/89	Kondraske	364-		
TV	BC	4,907,167	03/06/90	Skeirik	-364	<del>590</del>	
TV	BD	4,924,418	05/08/90	Backman et al.	-364		
$\mathcal{T}$	BE	4,934,196	06/19/90	Romano	73	861.38	RECEIVED
TV	BF	4,939,753	07/03/90	Olson	375	107	DEC 1 3 2001
TV	BG	4,964,125	10/16/90	Kim	371	15.1	
TV	BH	4,988,990	01/29/91	Warrior	340	25.5 Te	chnology Center 2100
72	BI	4,992,965	02/12/91	Holter et al.	<del>~364→</del>	+551.01	· .
TV	BJ	5,005,142	04/02/91	Lipchak et al.	364	-550-	
TV	BK	5,043,862	08/27/91	Takahashi et al.	364	-162-	
TV	BL	5,053,815	10/01/91	Wendell	355	208	
	BM	5,067,099	11/19/91	McCown et al.			
TV TV	BN	5,081,598	01/14/92	Bellows et al.	<del>•364</del> -		
$\neg \checkmark$	во	5,089,984	02/18/92	Struger et al.	-395	- <u>-650-</u> -	
5	BP	5,098,197	03/24/92	Shepard et al.	374	· 120	
4	BQ	5,099,436	03/24/92	McCown et al.		<del>~550 ~</del>	
$\gamma$	BR	5,103,409	04/07/92	Shimizu et al.		<del>556</del> -	
7	BS	5,111,531	05/05/92	Grayson et al.	395	23	
TV	BT	5,121,467	06/09/92	Skeirik	<del>~-39</del> 5	-11	
N	BU	5,122,794	06/16/92	Warrior	340	825.2	
72	BV	5,122,976	06/16/92	Bellows et al.		-550-	
TV.	BW	5,130,936	07/14/92	Sheppard et al.	_364_	<del>551.01</del>	
T	BX	5,134,574	07/28/92	Beaverstock et al.	-364	551_01	
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM	PTO-14	149				tty. Docket <b>32.12-0019</b>	No.:	Appl. No.: 09/972,078
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TV	CA	5,137,370	08/11/92	McCullock et al.		374	173	· · · · · · · · · · · · · · · · · · ·
TV TV	СВ	5,142,612	08/25/92	Skeirik				
TV	сс	5,143,452	09/01/92	Maxedon et al.		374	170	
TV	CD	5,148,378	09/15/92	Shibayama et al.		-364 -	<u>-551.07</u>	REACH
TV.	CE	5,167,009	11/24/92	Skeirik		-395-	<del>. 27 -</del>	TECEIVED
72	CF·	5,175,678	12/29/92	Frerichs et al.		-364-	<del>148-</del>	DEC 1 3 2001
N.	CG	5,193,143	03/09/93	Kaemmerer et al.		-395-	<u>-51</u> 7	
$\mathcal{T}^{\mathcal{V}}$	СН	5,197,114	03/23/93	Skeirik		<del>~395</del>	-22	echnology Center 21
N.	CI	5,197,328	03/30/93	Fitzgerald		73	168	· .
TV	CJ	5,212,765	05/18/93 .	Skeirik		395	<del>-11</del>	
N	СК	5,214,582	05/25/93	Gray		364	-424.03	
$\mathcal{T}$	CL	5,224,203	06/29/93	Skeirik		-395-	- <del>22-</del>	
Tr	СМ	5,228,780	07/20/93	Shepard et al.		374	175	
TV	CN	5,235,527	08/10/93	Ogawa et al.			• <del>571:05</del>	
TV	со	5,265,031	11/23/93	Malczewski		364	<del>-497-</del>	
TV_	CP	5,265,222	11/23/93	Nishiya et al.		395	-3-	
TV	CQ	5,274,572	12/28/93	O'Neill et al.		-364	-550	
777723	CR	5,282,131	01/25/94	Rudd et al.		<del>~364</del>	-164	
$\gamma$	CS	5,282,261	01/25/94	Skeirik			-22	
$\gamma$	СТ	5,293,585	03/08/94	Morita		395-		
N	CU	5,303,181	04/12/94	Stockton		365	96	
TV	CV	5,305,230	04/19/94	Matsumoto et al.			495	
TV.	CW	5,311,421	05/10/94	Nomura et al.			• <del>157</del>	
$\sim$	СХ	5,317,520	05/31/94	Castle		-364-	<del>-482</del> -	

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				U.S. PATENT D	OCUMENTS					
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TV Di	A	5,327,357	07/05/94	Feinstein e	t al.		-364-	-502-		
D	В	5,333,240	07/26/94	Matsumoto et	t al.		<del>⊷ 395</del>	_23		
D	С	5,349,541	09/20/94	Alexandro,	Jr. et al		- 364	-578-		
Di	D	5,357,449	10/18/94	Oh	<b>.</b>		-364	~55 <del>1.01</del>		
D	E	5,361,628	11/08/94	Marko et al	•		73	116		
D	F	5,365,423	11/15/94	Chand			-364	-140-		
D	G	5,367,612	11/22/94	Bozich et a	l.		395-	-22-		
Di	н	5,384,699	01/24/95	Levy et al.			-364	<del>, 413.13</del>	RECEIVED	
D	I	5,386,373	01/31/95	Keeler et al	L.		<del>- 364</del>	- 577-	DEC 1 9 000	
D	J	5,394,341	02/28/95	Kepner	•		-364-	_551_01	DEC 1 3 2001	
DI	к	5,394,543	02/28/95	Hill et al.			-395	<- 575 Tec	hnology Center 21	
D	L	5,404,064	04/04/95	Mermelstein	et al.		310	319		
DI	м	5,408,406	04/18/95	Mathur et al	L.		364	-163		
DI	N	5,408,586	04/18/95	Skeirik			395			
D	0	5,414,645	05/09/95	Hirano				-551.01		
Di	Р	5,419,197	05/30/95	Ogi et al.			73	659		
D	Q	5,430,642	07/04/95	Nakajima et	al.			_148_		
DI	R	5,440,478	08/08/95	Fisher et al	L.		-364-	<del>- 188 -</del>		
D	s	5,442,639	08/15/95	Crowder et a	al.		371	20.1		
D	т	5,467,355	11/14/95	Umeda et al.	,		364-	<del>571.04</del>		
D	U	5,469,070	11/21/95	Koluvek			324	713		
D	v	5,469,156	11/21/95	Kogura			340	870.38		
	W	5,469,735	11/28/95	Watanabe			73	118.1		
-1-	x	5,481,199	01/02/96	Anderson et	al		324	705	· · · · ·	

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72	EA	5,483,387	01/09/96	Bauhahn et al.		359	885		
1	EB	5,485,753	01/23/96	Burns et al.		73	720		
	ÉC	5,486,996	01/23/96	Samad et al.		<u> </u>	<del>~ 152</del>		
T	ED	5,488,697	01/30/96	Kaemmerer et al.		<del>· 395</del>	51		
Τ	EE	5,489,831	02/06/96	Harris		318	701		
	EF	5,495,769	05/03/96	Broden et al.		73	718		
Τ	EG	5,510,779	04/23/96	Maltby et al.		340	870.300		
	EH	5,511,004	04/23/96	Dubost et al.		-364-	<del>-551:01-</del>		
	EI	5,548,528	08/20/96	Keeler et al.		<del>~364</del>	-497		
	EJ	5,561,599	10/01/96	Lu			<u>►164</u>	RECEIVED	
	EK	5,570,300	10/29/96	Henry et al.			_551.01	DEC 1 3 2001	
	EK	5,572,420	11/05/96	Lu		<del>~-364 ·</del> ·	_153		
	ĒL	5,573,032	11/12/96	Lenz et al.		137	486	Technology Center 2	
	EM	5,598,521	01/28/97	Kilgore et al.	1 × 1000 000	<del>~395</del>			
	EN	5,600,148	02/04/97	Cole et al.		250	495.1		
	EO	5,623,605	04/22/97	Keshav et al.		<del>395</del> -	200 17		
	EP	5,640,491	06/17/97	Bhat et al.	_				
	EQ	5,661,668	08/26/97	Yemini et al.			<del>~ 550 _</del>		
	ER	5,665,899	07/09/97	Willcox		73	1.63		
	ES	5,671,335	09/23/97	Davis et al.		<del>_395</del> _	-23-		
	ET	5,675,504	10/07/97	Serodes et al.		-364-	-496-		
	EU	5,675,724	10/07/97	Beal et al.			<u>-182-02</u>		
	EV	5,704,011	12/30/97	Hansen et al.			<del>22</del>		
$\checkmark$	EW	5,705,978	01/06/98	Frick et al.		340	511		
TV	EX ·	5,708,585	01/13/98	Kushion		-364	-431-061		

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TV	FA	5,713,668	02/03/98	Lunghofer et al.		374	179	
1	FB	5,742,845	04/21/98	Wagner		<del>395</del> -	- 831	
1	FC	5,746,511	05/05/98	Eryurek et al.		374	2	· · · ·
	FD	5,752,008	05/12/98	Bowling		395	_500-	
	FE	5,764,891	06/09/98	Warrior		<del>~395</del>	-200.2	
	FF	5,781,878	07/14/98	Mizoguchi et al.		701	109	
	FG	5,801,689	09/01/98	Huntsman		345	329	
	FH	5,805,442	09/08/98	Crater et al.		-364-	<u>_138</u>	
	FI	5,828,567	10/27/98	Eryurek et al.		700	79	
	FJ	5,859,964	01/12/99	Wang et al.		395-	<del>185.01</del>	
	FK	5,887,978	03/30/99	Lunghofer et al.		374	179	TECEIVED
	FK	5,923,557	07/13/99	Eidson			471.03	D 132001
	FL	5,924,086	07/13/99	Mathur et al.		706	25	thology Center 210
	FM	5,940,290	08/17/99	Dixon		<del>~364</del> -	-138-	monda center 510
	FN	5,956,663	09/21/99.	Eryurek et al.		702	183	
	FO	5,970,430	10/19/99	Burns et al.		702	122	
	FP	6,016,706	01/25/00	Yamamoto et al.		9	6	
	FQ	6,017,143	01/25/00	Eryurek et al.		700	51	
	FR	6,047,220	04/04/00	Eryurek et al.		700	28	
	FS	6,047,222	04/04/00	Burns et al.		700	79	
	FT	6,119,047	09/12/00	Eryurek et al.		700	28	
	FU	6,199,018 B1	03/06/01	Quist et al.		702	34	
	FV	5,347,843	09/20/94	Orr et al.		73	3	
$\mathbf{V}_{-}$	FW	5,637,802	06/10/97	Frick et al.		73	724	
$\mathcal{N}$	FX	5,680,109	10/21/97	Lowe et al.		340	608	
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		Sheet 7 of 1
FORM PTO-1449	Atty. Docket No.: <b>P32.12-0019</b>	Appl. No.: 09/972,078
LIST OF PATENTS AND PUBLICATION APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Invento	r:
(J DEC 1 2 2001 2)	Evren Eryurek et al	•
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TV	GA	09/169,873	10/12/98	Eryurek-et_al				
1	GB	09/175,832	10/19/98	Eryurek et al.		· · · · · · · · · · · · · · · · · · ·		
	-00-	09/257,896	02/25/99	Ervurek_et_a].				
	-GD	-09/303,869-	-05/03/99	Eryurck ot al.				
	GE	-09/335,212-	06/17/99	Kirkpatrick-et-al-				
	GF	09/344,631-	06/25/99	Eryurek et-al.				
	GG	09/360,473	07/23/99	Eryurek et al.				· ·
	GH	09/369,530	08/06/99	Eryurek et al.				
$\top$	GI	09/383,820-	08/27/99	Eryurek et al.		1		
	ĢI	-09/384,876	08/27/99-	Eryurek et al				RECEIVED
	<del>SK</del>	09/406,283	09/24/99	Kirkpatrick et al.		1		
$\top$	GL	097409,098	09/30/99	Eryurek et al.		1		DEC 1 3 2001
	•GM	- 09/409,114-	09/30/99	Ervurek et al.		1		Technology Center 21
	<u>CN</u>	-09/565,604	05/04/00	Eruyrek ot al		1		
	GO	09/576,450	-05/23/00	David L. Wehrs-		1		· · · · · · · · · · · · · · · · · · ·
	-GP	09/606,259	06/29/00-	Evren Eryarek				
	<del>60</del>	09/616,118	07/14/00	Eryurek et al		ļļ		
	•GR	09/627,543-	07/28/00	Eryurek et al.		ļ,		
	-66	09/576,719	05/23/00	Coursolle et al.		ļ		
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	-CU	-09/855,179-	05/14/01-	Eryurek_et_al		1		
	GV	4,399,824	08/23/83	Davidson		128	736	
	GW	5,269,311	12/14/93	Kirchner et al.		128	672	
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TV	HA	WO 94/25933	11/10/94	WIPO		ــــــ		Х	
1	нв 🕻	WO 96/11389	04/18/96	WIPO				Х	
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	HD 🖌	WO 96/39617	12/12/96	WIPO		-		X	
	HE	WO 97/21157	06/12/97	WIPO				Х	
	HF,	WO 97/25603	07/17/97	WIPO				Х	
	HG 🆌	WO 98/06024	02/12/98	WIPO				Х	
	нн 🖌	WO 98/20469	05/14/98	WIPO				Х	
	HI /	0 122 622 A1	10/24/84	EPO		<		х	
	HJ /	0 413 814 A1	02/27/91	EPO				Χ.	
	HK .	0 624 847 A1	11/17/94	EPO			Pr	X (Abst	tract
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	HQ /	EP 0 838 768 A2	09/24/97	EPO				х	
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	ни 🖌	DE 44 33 593 A1	06/01/95	Germany				X (Abst	cract
	HV	DE 195 02 499 A1	08/01/96	Germany				X (Abst	ract
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	IK 🖊	2-5105	01/10/90	Japan		·		X (Abst	ract
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	IM ,	06242192	09/02/94	Japan		e		X (Abst	ract)
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	IU /	928,704	06/12/63	United Kingdo	m			X	
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	JB 🖊	2 334 827	07/08/77	France				X (Abstract)	
	JC	JP 07225530	05/1998	Japan				ABSTRACT ONLY	
	JD	DE 43 43 747	06/1994	Germany					
	JE	WO 98/13677	04/1998	WIPO					
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